

• General Description

The CH20N04A combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$. This device is ideal for load switch and battery protection applications.

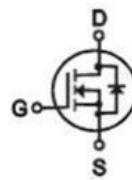
• Features

- Advance high cell density Trench technology
- Low $R_{DS(ON)}$ to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance

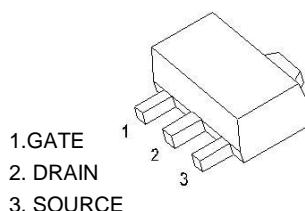
• Application

- MB/VGA Vcore
- SMPS 2 Synchronous Rectifier
- POL application
- BLDC Motor driver

• Product Summary


 $V_{DS} = 40V$
 $R_{DS(ON)} = 16m\Omega$
 $I_D = 20A$

SOT-89-3L



• Ordering Information:

Part NO.	CH20N04A
Marking	20N04A
Packing Information	REEL TAPE
Basic ordering unit (pcs)	1000

• Absolute Maximum Ratings ($T_c = 25^\circ C$)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	40	V
Gate-Source Voltage	V_{GS}	20	V
Continuous Drain Current	$I_D@T_c=25^\circ C$	20	A
	$I_D@T_c=75^\circ C$	15	A
	$I_D@T_c=100^\circ C$	10	A
Pulsed Drain Current	I_{DM}	100	A
Total Power Dissipation($T_c=25^\circ C$)	$P_D@T_c=25^\circ C$	30	W
Total Power Dissipation($T_A=100^\circ C$)	$P_D@T_c=100^\circ C$	15	W
Operating Junction Temperature	T_J	-55 to 175	°C
Storage Temperature	T_{STG}	-55 to 175	°C
Single Pulse Avalanche Energy@ $L=0.1mH$	E_{AS}	150	mJ
Avalanche Current@ $L=0.1mH$	I_{AS}	55	A

•Thermal resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	R _{thJC}	-	4		°C/W
Thermal resistance, junction - ambient	R _{thJA}	-	-	100	°C/W
Soldering temperature, wavesoldering for 10s	T _{sold}	-	-	125	°C

•Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =250μA	40			V
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} =V _{DS} , I _D =250μA	1	1.6	2.1	V
Drain-Source Leakage Current	I _{DSS}	V _{DS} =20V, V _{GS} =0V			1.0	uA
Gate- Source Leakage Current	I _{GSS}	V _{GS} =+12V ,V _{DS} =0V			±100	nA
Static Drain-source On Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =1A		16	18	mΩ
		V _{GS} =4.5V, ID=1A		18	22	mΩ
Forward Transconductance	g _{FS}	V _{DS} =15V, I _D =10A		18		s
Source-drain voltage	V _{SD}	I _S =1A			1.0	V

•Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Input capacitance	C _{iss}	f = 1MHz	-	840	-	pF
Output capacitance	C _{oss}		-	92	-	
Reverse transfer capacitance	C _{rss}		-	60	-	

•Gate Charge characteristics(T_a = 25°C)

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Total gate charge	Q _g	V _{DS} =10V I _D = 25A V _{GS} = 10V	-	20	-	nC
Gate - Source charge	Q _{gs}		-	2.5	-	
Gate - Drain charge	Q _{gd}		-	4.5	-	

Note: ① Pulse Test : Pulse width ≤ 300μs, Duty cycle ≤ 2% ;

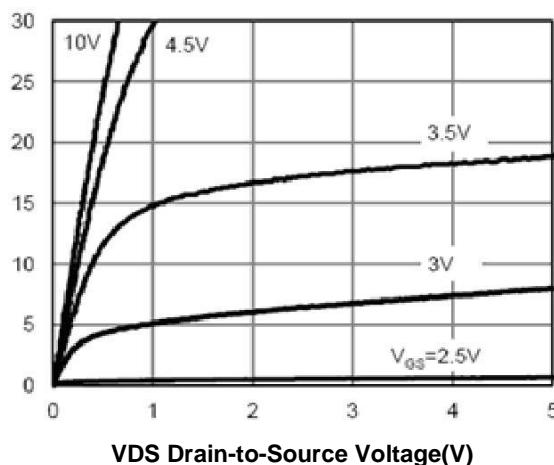
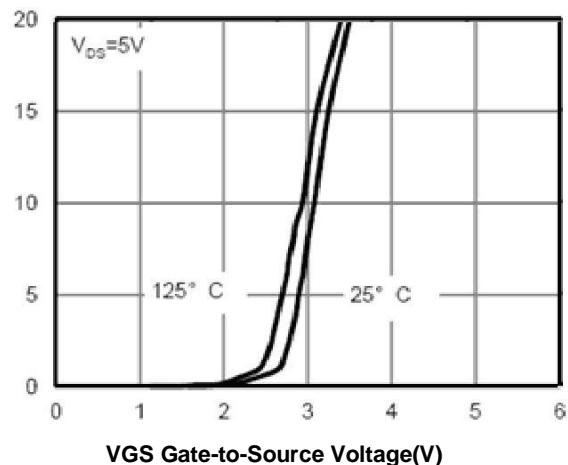
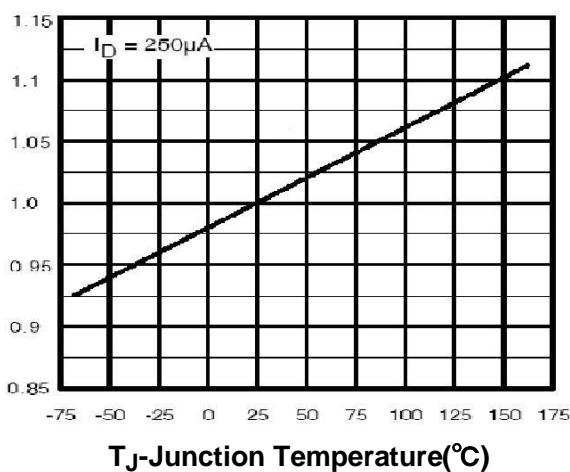
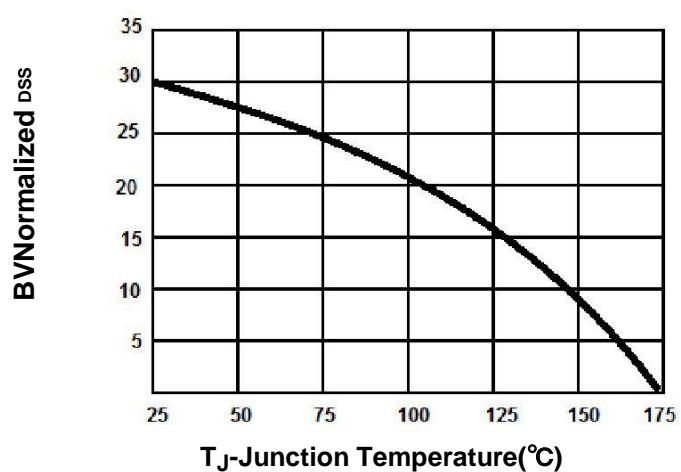
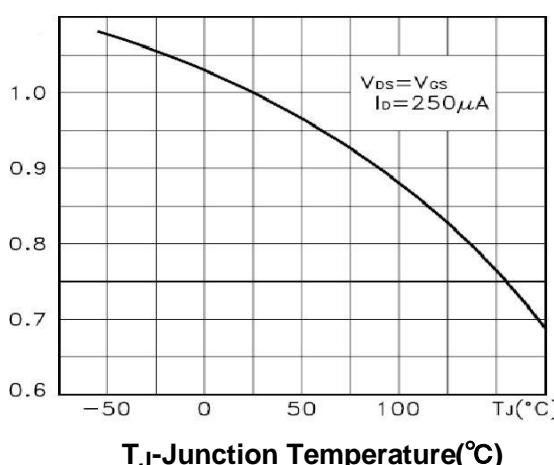
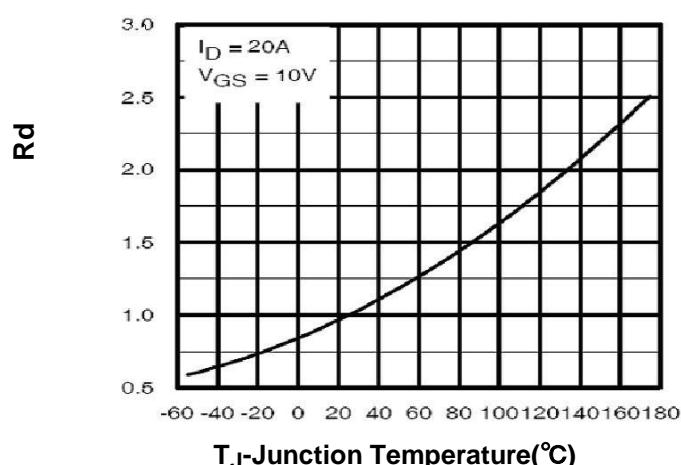
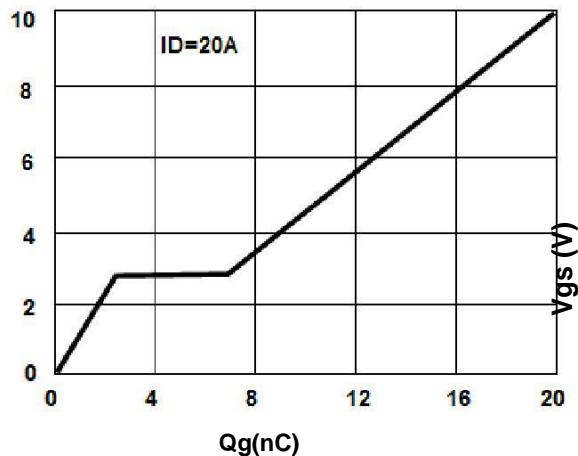
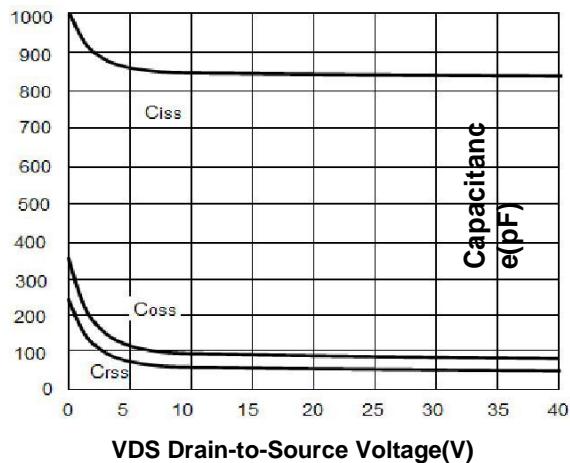
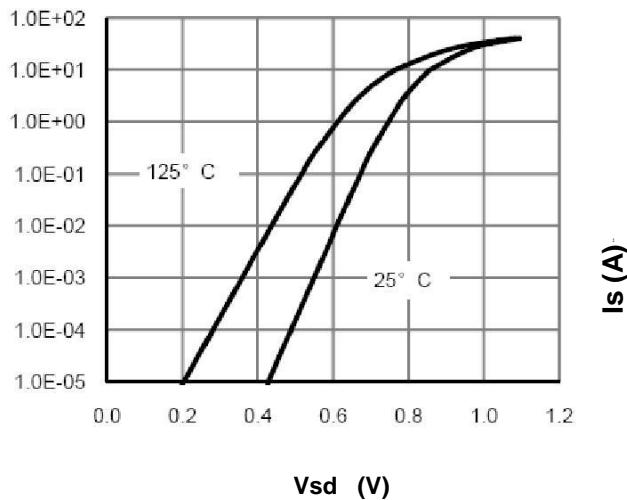
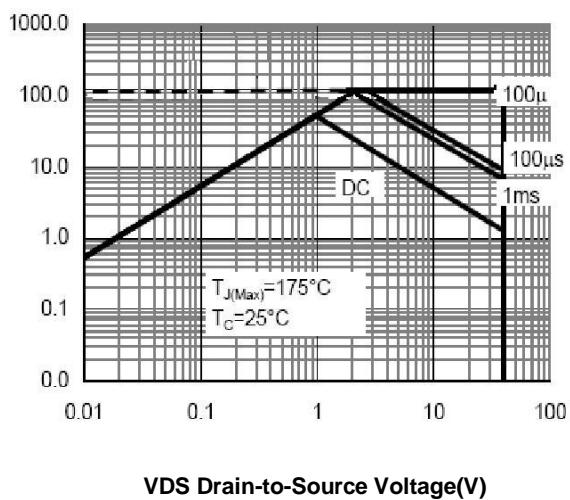
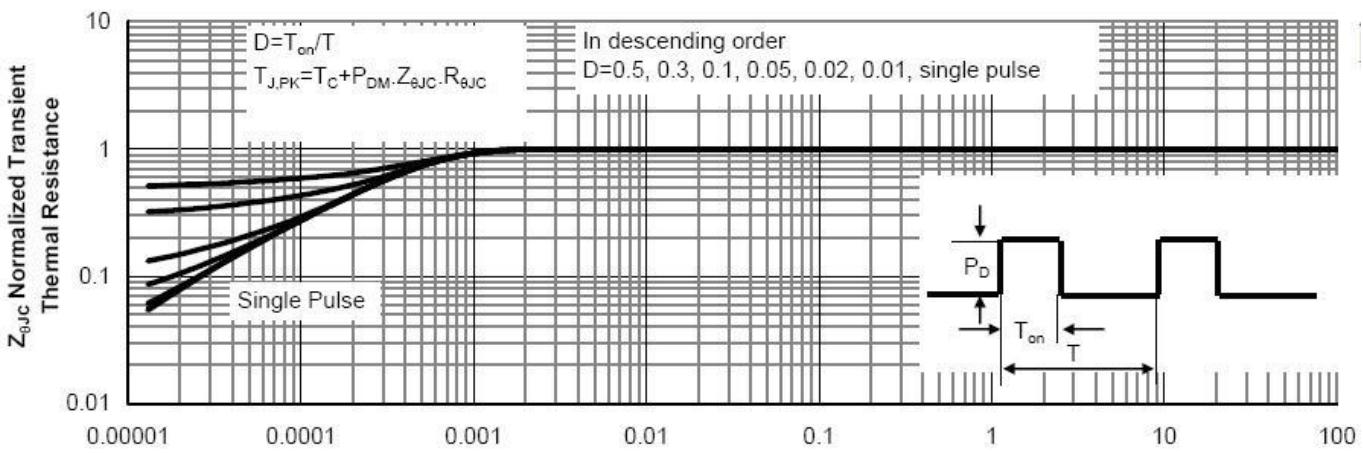
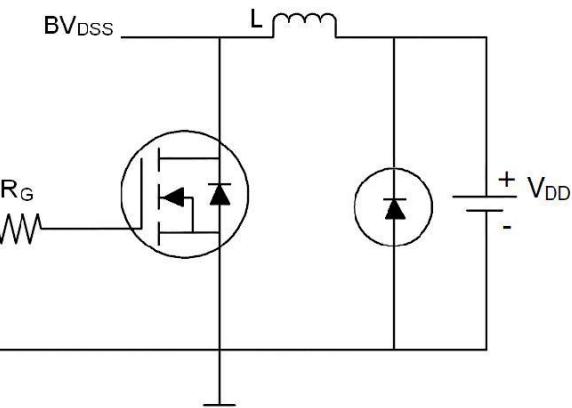
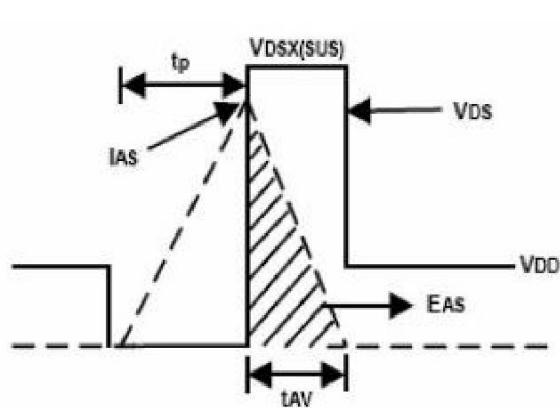
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS (Curves)
Figure 1. Output Characteristics

Figure 2. Transfer Characteristics

Figure 3. Max BV_{DSS} vs Junction Temperature

Figure 4. Drain Current

Figure 5. $V_{GS(th)}$ vs Junction Temperature

Figure 6. $R_{DS(ON)}$ vs Junction Temperature


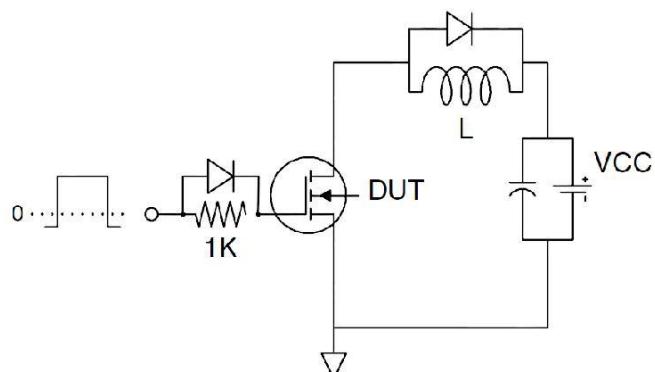
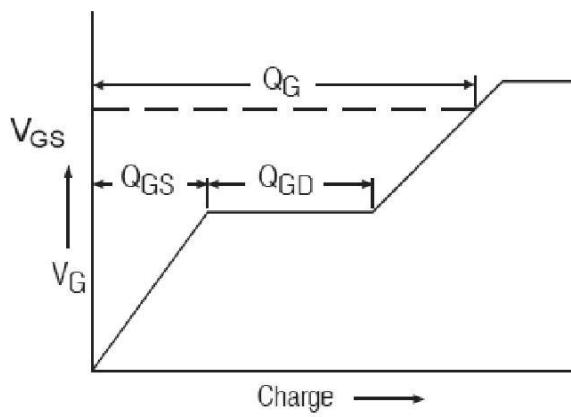
Figure 7. Gate Charge Waveforms

Figure 8. Capacitance

Figure 9. Body-Diode Characteristics

Figure 10. Maximum Safe Operating Area

Figure 11. Normalized Maximum Transient Thermal Impedance


Test Circuit

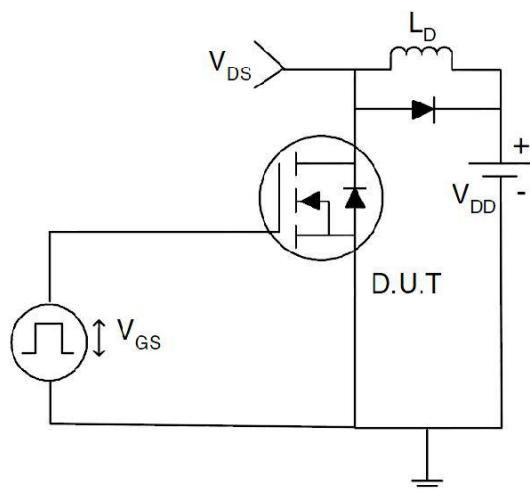
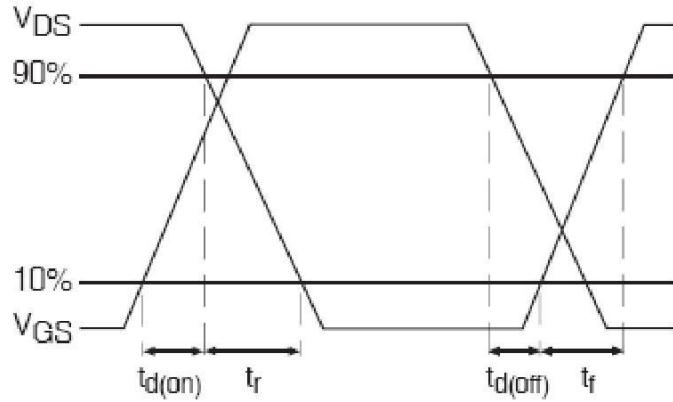
1) E_{AS} Test Circuits

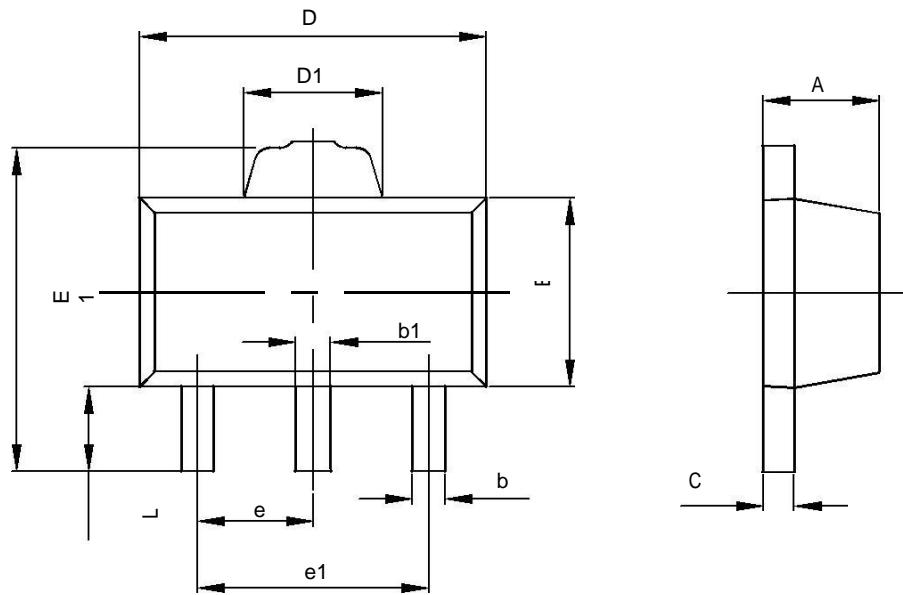


2) Gate Charge Test Circuit:



3) Switch Time Test Circuit:



SOT-89-3L PACKAGE OUTLINE DIMENSIONS


Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	1.400	1.600	0.055	0.063
b	0.320	0.520	0.013	0.020
b1	0.360	0.560	0.014	0.022
c	0.350	0.440	0.014	0.017
D	4.400	4.600	0.173	0.181
D1	1.400	1.800	0.055	0.071
E	2.300	2.600	0.091	0.102
E1	3.940	4.250	0.155	0.167
e	1.500TYP		0.060TYP	
e1	2.900	3.100	0.114	0.122
L	0.900	1.100	0.035	0.043